


<b>Search Notes</b> 	<b>Application/Control No.</b> 10736605	<b>Applicant(s)/Patent Under Reexamination</b> HIROSE ET AL.
	<b>Examiner</b> Tran, Thien F	<b>Art Unit</b> 2811

SEARCHED			
Class	Subclass	Date	Examiner
438	46-47, 92-94, 167, 172, 181, 197, 287, 570, 604, 606, 718	12/13/06	TT
above	updated	03/16/07	TT

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner